

<b>Notice of References Cited</b>	Application/Control No. 10/707,796	Applicant(s)/Patent Under Reexamination INABA ET AL.	
	Examiner Hien D. Vu	Art Unit 2833	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,915,637	04-1990	Ogawa et al.	439/76.2
	B	US-5,129,841	07-1992	Allina et al.	439/517
	C	US-6,379,195	04-2002	Torikoshi et al.	439/733.1
	D	US-4,703,397	10-1987	Minoura et al.	361/826
	E	US-5,764,487	06-1998	Natsume, Yoshihisa	361/775
	F	US-1,906,976	05-1933	LAZARUS LOUIS M	200/51.03
	G	US-4,090,769	05-1978	Damsky, Arnold	439/650
	H	US-3,242,455	03-1966	HORVATH JOHN C; et. al.	439/105
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.